

Search Notes**Application/Control No.**

10/656,452

Examiner

Chris C. Chu

Applicant(s)/Patent under Reexamination

ELLSBERRY ET AL.

Art Unit

2815

SEARCHED

Class	Subclass	Date	Examiner
257	E25.006, E25.013 & E21.511	4/7/2005	C.C.
257	E23.069	4/7/2005	C.C.
257	686 & 777	4/7/2005	C.C.
257	778 & 786	4/7/2005	C.C.
257	780 & 781	4/7/2005	C.C.
257	712 & 713	4/7/2005	C.C.
257	747 & 692	4/7/2005	C.C.
257	693 & 698	4/7/2005	C.C.
257	723 & 737	4/7/2005	C.C.
257	738 & 778	4/7/2005	C.C.
361	783 & 803	4/7/2005	C.C.

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched in US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; and IBM_TDB;	4/7/2005	C.C.
Consulted with Clark, Sheila 257/686, 777, 778, 786, 780 & 781	4/6/2005	C.C.
Consulted with Jackson, Jerome 257/712, 713 & 747	4/6/2005	C.C.
Consulted with Graybill, David 257/686, 692, 693, 698, 723, 737, 738, 778, 786, E25.006, E25.013, E21.511 & E23.069	4/6/2005	C.C.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner